



**INFORMATION DISCLOSURE
CITATION**

PTO-1449

ATTORNEY'S DOCKET NO.:

98-34CON1

APPLICATION NO.:

10/803,115

APPLICANT:

Crevier et al.

FILING DATE:

March 16, 2004

CONFIRMATION No.:

GROUP:

1645

US PATENT DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	NAME	CLASS	SUBCLASS	FILING DATE
	Re. 36,529	1/25/00	Lewis et al.	356	346	12/23/97
	3,030,917	4/24/62	Brown et al.	118	413	8/13/58
	4,998,284	3/5/91	Bacus et al.	382	6	2/24/89
	5,127,063	6/30/92	Nishiya et al.	382	8	9/20/89
	5,143,854	9/1/92	Pirrung et al.	436	518	3/07/90
	5,549,996	8/27/96	Bollen	430	21	3/14/95
	5,571,639	11/5/96	Hubbell et al.	430	5	5/24/94
	5,631,734	5/20/97	Stern et al.	356	317	2/10/94
	5,776,359	7/07/98	Schultz et al.	252	62.51	5/08/95
	5,792,610	8/11/98	Witney et al.	435	6	5/01/96
	5,856,101	1/5/99	Hubbell et al.	435	6	9/27/96
	5,974,164	10/26/99	Chee	382	129	10/16/95
	5,991,028	11/23/99	Cabib et al.	356	346	3/25/97
	6,025,601	2/15/00	Trulson et al.	250	461.2	6/09/97
	6,030,917	2/29/00	Weinberg et al.	502	104	7/22/97
	6,044,212	3/28/00	Flavin et al.	703	6	5/23/97
	6,101,265	8/08/00	Bacus et al.	382	133	3/03/97
	6,184,389	2/06/01	Hebert, Normand	549	6	6/07/95
	6,316,626	11/13/01	Swayze et al.	546	207	9/04/98

FOREIGN DOCUMENTS

EXAMINER'S INITIALS	PATENT NO.	DATE	COUNTRY	CLASS	SUB CLASS	TRANSLATION ?
	0 535 881	4/7/93	EPO			
	WO 96/11878	4/25/96	PCT			
	WO 97/32208	9/4/97	PCT			
	WO 99/34206	7/8/99	PCT			



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	APPLICANT: Crevier et al.		
	FILING DATE: March 16, 2004	CONFIRMATION No.: 	GROUP: 1645
OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages Etc.)			
<input checked="" type="checkbox"/>	Briceño et al., "A Class of Cobalt Oxide Magnetoresistance Materials Discovered with Combinatorial Synthesis", <i>Science</i> , Vol. 270, October 13, 1995, pp. 273-275.		
<input type="checkbox"/>	Danielson et al., "A Combinatorial Approach to the Discovery and Optimization of Luminescent Materials", <i>Nature</i> , Vol. 389, October 30, 1997, pp. 944-948.		
<input type="checkbox"/>	Dersch et al., "Optical Approach to Thermopower and Conductivity Measurements in Thin-Film Semiconductors", <i>Applied Physics Letters</i> , Vol. 45, No. 3, August 1, 1984, 272-274.		
<input type="checkbox"/>	Georgiades et al., "IR Emission Analysis of Temperature Profiles in Pt/SiO ₂ Catalysts During Exothermic Reactions", <i>Angew. Chem. Int. Ed. Engl.</i> 26, No. 10, 1987, 1042-1043.		
<input type="checkbox"/>	Hanak, J.J., "The "Multiple-Sample Concept" in Materials Research: Synthesis, Compositional Analysis and Testing of Entire Multicomponent Systems", <i>Journal of Materials Sciences</i> , 1970, pp. 964-971.		
<input type="checkbox"/>	Hardisty et al., "Thermal Imaging in Electronics and Rotating Machinery", <i>British Journal of NDT</i> , 32 nd Annual British Conf. On Non-Destructive Testing, Vol 36, February 1994, pp. 73-78.		
<input type="checkbox"/>	Holzwarth et al., "Detection of Catalytic Activity in Combinatorial Libraries of Heterogeneous Catalysts by IR Thermography", <i>Angew. Chem. Int. Ed.</i> , Vol. 37, No. 19, 1998, pp.2644-2647.		
<input type="checkbox"/>	Hsieh-Wilson et al., "Lessons from the Immune System: From Catalysis to Materials Science", <i>Acc. Chem. Res.</i> , Vol. 29, 1996, pp. 164-170.		
<input type="checkbox"/>	Jandeleit et al., "Combinatorial Methods in Catalysis", <i>Baltzer Science Publishers</i> , Vol. 2, No. 2, December 1998, pp. 101-123.		
<input type="checkbox"/>	Lewis et al., "Fourier Transform Spectroscopic Imaging Using an Infrared Focal-Plane Array Detector", <i>Anal. Chem.</i> , 67, 1995, pp. 3377-3381.		
<input type="checkbox"/>	McFarland et al., "Approaches for Rapid Materials Discovery Using Combinatorial Methods", <i>Mat. Tech.</i> , 13.3, 1998, pp. 107-120.		
<input type="checkbox"/>	Moates et al., "Infrared Thermographic Screening of Combinatorial Libraries of Heterogeneous Catalysts", <i>Ind. Eng. Chem. Res.</i> , 35, 1996, pp. 4801-4803.		
<input type="checkbox"/>	Moates et al., "Infrared Thermographic Screening of Combinatorial Libraries of Heterogeneous Catalysts", <i>Screening Catalyst Activity</i> , August 1997, pp. 683-686.		
<input type="checkbox"/>	Network Science, "Introducing MDL Screen", http://www.netsci.org/Science/Screening/feature03.html , downloaded on November 15, 2002,		
<input type="checkbox"/>	Pawlicki et al., "Spatial Effects on Supported Catalysts", <i>Chem. Eng. Progress</i> , 2/87, pp. 40-45.		
<input type="checkbox"/>	PCT International Search Report, PCT/US99/07358, August 16, 1999.		
<input type="checkbox"/>	Reddington et al., "Combinatorial Electrochemistry: A Highly Parallel, Optical Screening Method for Discovery of Better Electrocatalysts", <i>Science</i> , Vol. 280, June 12, 1998, pp. 1735-1737.		
<input type="checkbox"/>	Reetz, M.T. et al., "Time-Resolved IR-Thermographic Detection and Screening of Enantioselectivity in Catalytic Reactions", <i>Angew. Chem. Int. Ed.</i> , Vol. 37, 1998, pp. 2647-2650.		
<input type="checkbox"/>	Service, Robert F., "High-Speed Materials Design", <i>Science</i> , Vol. 277, July 1997, pp. 474-475.		
<input type="checkbox"/>	Sun, Xiao-Dong et al., "Solution-Phase Synthesis of Luminescent Materials Libraries", <i>Adv. Mater.</i> , Vol. 9, No. 13, 1997, pp. 1046-1049.		
<input type="checkbox"/>	Sun, Xiao-Dong et al., "Identification and Optimization of Advanced Phosphors Using Combinatorial Libraries", <i>American Institute of Physics</i> , Vol. 70, No. 25, 1997, pp. 3353-3355.		
<input type="checkbox"/>	Sun, Xiao-Dong et al., "A Combinatorial Approach to Materials Discovery", <i>Science</i> , Vol. 268, June 23, 1995, pp. 1738-1740.		
<input checked="" type="checkbox"/>	Taylor et al., "Thermographic Selection of Effective Catalysts from an Encoded Polymer-Bound Library", <i>Science</i> , Vol. 280, April 10, 1998, pp. 267-270.		
EXAMINER:	DATE CONSIDERED:		11/3/05

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